

# RGT40NL65D

#### 650V 20A Field Stop Trench IGBT

V <sub>CES</sub>	650V
I <sub>C(100°C)</sub>	20A
V <sub>CE(sat) (Typ.)</sub>	1.65V
$P_D$	161W

#### Features

- 1) Low Collector Emitter Saturation Voltage
- 2) Low Switching Loss
- 3) Short Circuit Withstand Time 5µs
- 4) Built in Very Fast & Soft Recovery FRD (RFN - Series)
- 5) Pb free Lead Plating; RoHS Compliant

#### Applications

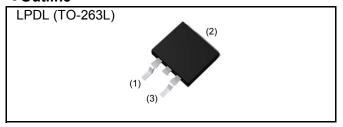
**General Inverter** 

**UPS** 

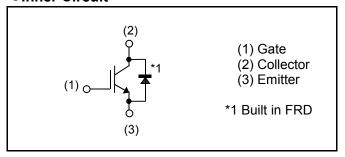
**Power Conditioner** 

Welder

#### Outline



#### ●Inner Circuit



#### Packaging Specifications

	Packaging	Taping
	Reel Size (mm)	330
Typo	Tape Width (mm)	24
Туре	Basic Ordering Unit (pcs)	1,000
	Packing Code	TL
	Marking	RGT40NL65D

## ● Absolute Maximum Ratings (at T<sub>C</sub> = 25°C unless otherwise specified)

Parameter		Symbol	Value	Unit	
Collector - Emitter Voltage		$V_{CES}$	650	V	
Gate - Emitter Voltage		$V_{GES}$	±30	V	
Collector Current	T <sub>C</sub> = 25°C	I <sub>C</sub>	40	А	
Collector Current	T <sub>C</sub> = 100°C	I <sub>C</sub>	20	А	
Pulsed Collector Current		I <sub>CP</sub> *1	I <sub>CP</sub> *1 60		
Diode Forward Current	T <sub>C</sub> = 25°C	I <sub>F</sub>	35	А	
	T <sub>C</sub> = 100°C	I <sub>F</sub>	20	А	
Diode Pulsed Forward Current		I <sub>FP</sub> *1	I <sub>FP</sub> *1 60		
Power Dissipation	T <sub>C</sub> = 25°C	P <sub>D</sub>	161	W	
	T <sub>C</sub> = 100°C	P <sub>D</sub>	70	W	
Operating Junction Temperature		T <sub>j</sub>	-40 to +175	°C	
Storage Temperature		T <sub>stg</sub>	-55 to +175	°C	

<sup>\*1</sup> Pulse width limited by T<sub>jmax.</sub>

#### ●Thermal Resistance

Parameter	Symbol	Values			Unit
- Farameter		Min.	Тур.	Max.	Offic
Thermal Resistance IGBT Junction - Case	$R_{\theta(j-c)}$	-	ı	0.93	°C/W
Thermal Resistance Diode Junction - Case	$R_{\theta(j-c)}$	-	1	2.12	°C/W

# ●IGBT Electrical Characteristics (at T<sub>j</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Values			Unit
r ai ai iletei			Min.	Тур.	Max.	Unit
Collector - Emitter Breakdown Voltage	BV <sub>CES</sub>	$I_C = 10 \mu A, V_{GE} = 0 V$	650	-	-	V
Collector Cut - off Current	I <sub>CES</sub>	V <sub>CE</sub> = 650V, V <sub>GE</sub> = 0V	1	1	10	μΑ
Gate - Emitter Leakage Current	I <sub>GES</sub>	$V_{GE} = \pm 30V, V_{CE} = 0V$	-	-	±200	nA
Gate - Emitter Threshold Voltage	$V_{\text{GE(th)}}$	$V_{CE} = 5V, I_{C} = 13.3 \text{mA}$	5.0	6.0	7.0	V
Collector - Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_C = 20A, V_{GE} = 15V$ $T_j = 25^{\circ}C$ $T_j = 175^{\circ}C$	-	1.65 2.15	2.1 -	V

# ullet IGBT Electrical Characteristics (at $T_j = 25$ °C unless otherwise specified)

Parameter	Symbol	Conditions -		Unit		
Farameter	Symbol		Min.	Тур.	Max.	Offic
Input Capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 30V	-	1070	-	
Output Capacitance	C <sub>oes</sub>	V <sub>GE</sub> = 0V	-	45	-	pF
Reverse Transfer Capacitance	C <sub>res</sub>	f = 1MHz	-	18	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>CE</sub> = 300V	-	40	-	
Gate - Emitter Charge	$Q_{ge}$	I <sub>C</sub> = 20A	-	9	-	nC
Gate - Collector Charge	$Q_{gc}$	V <sub>GE</sub> = 15V	-	15	-	
Turn - on Delay Time	t <sub>d(on)</sub>	I <sub>C</sub> = 20A, V <sub>CC</sub> = 400V	-	22	-	
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_G = 10\Omega$	-	27	-	ns
Turn - off Delay Time	$t_{d(off)}$	T <sub>j</sub> = 25°C	-	75	-	
Fall Time	t <sub>f</sub>	Inductive Load	-	60	-	
Turn - on Delay Time	t <sub>d(on)</sub>	I <sub>C</sub> = 20A, V <sub>CC</sub> = 400V	-	22	-	
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_{G} = 10\Omega$	-	29	-	20
Turn - off Delay Time	t <sub>d(off)</sub>	T <sub>j</sub> = 175°C	-	84	-	ns
Fall Time	t <sub>f</sub>	Inductive Load	-	120	-	
		I <sub>C</sub> = 60A, V <sub>CC</sub> = 520V				
Reverse Bias Safe Operating Area	RBSOA	$V_P = 650V, V_{GE} = 15V$	FU	LL SQUA	RE	-
		$R_G = 50\Omega, T_j = 175^{\circ}C$				
		V <sub>CC</sub> ≦ 360V				
Short Circuit Withstand Time	$t_{sc}$	V <sub>GE</sub> = 15V	5	-	-	μs
		T <sub>j</sub> = 25°C				

## ●FRD Electrical Characteristics (at T<sub>j</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Values			Linit
			Min.	Тур.	Max.	Unit
Diode Forward Voltage	V <sub>F</sub>	$I_F = 20A$ $T_j = 25^{\circ}C$ $T_j = 175^{\circ}C$	-	1.45 1.25	1.9 -	V
Diode Reverse Recovery Time	t <sub>rr</sub>	$I_F = 20A$ $V_{CC} = 400V$ $di_F/dt = 200A/\mu s$ $T_j = 25^{\circ}C$	-	58	-	ns
Diode Peak Reverse Recovery Current	I <sub>rr</sub>		-	6.3	-	А
Diode Reverse Recovery Charge	$Q_{rr}$		-	0.20	-	μC
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 20A	-	256	-	ns
Diode Peak Reverse Recovery Current	I <sub>rr</sub>	$V_{CC} = 400V$ $di_F/dt = 200A/\mu s$ $T_j = 175^{\circ}C$	-	10.4	-	А
Diode Reverse Recovery Charge	$Q_{rr}$		-	1.35	-	μC

Fig.1 Power Dissipation vs. Case Temperature

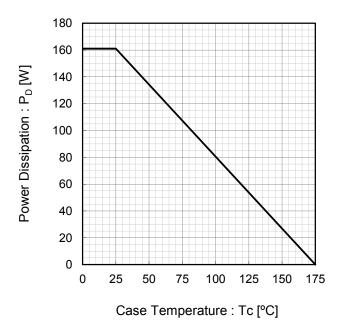


Fig.2 Collector Current vs. Case Temperature

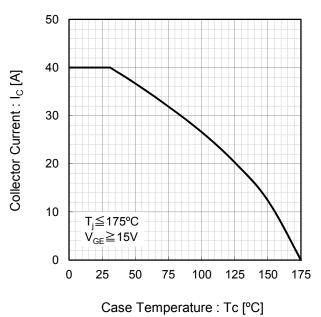
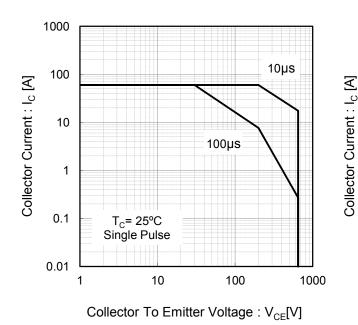


Fig.3 Forward Bias Safe Operating Area



80
60
40

T<sub>j</sub>≤175°C
V<sub>GE</sub>=15V
0
200 400 600 800

Fig.4 Reverse Bias Safe Operating Area

Collector To Emitter Voltage : V<sub>CE</sub>[V]

Fig.5 Typical Output Characteristics

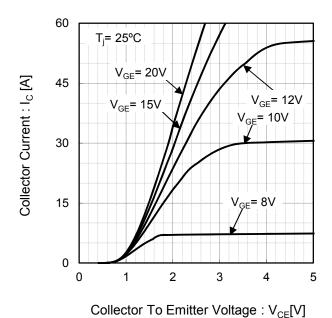
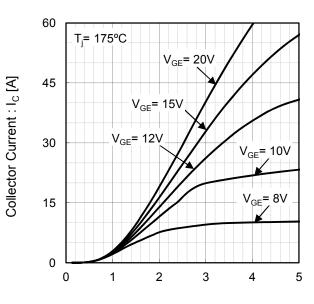


Fig.6 Typical Output Characteristics



Collector To Emitter Voltage : V<sub>CE</sub>[V]

Fig.7 Typical Transfer Characteristics

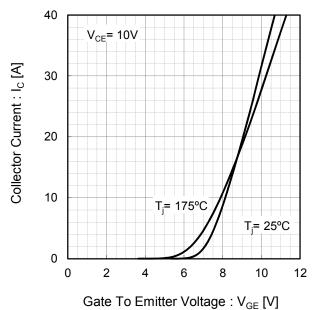


Fig.8 Typical Collector To Emitter Saturation Voltage vs. Junction Temperature

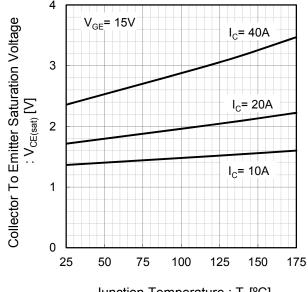
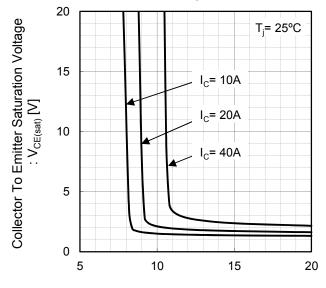
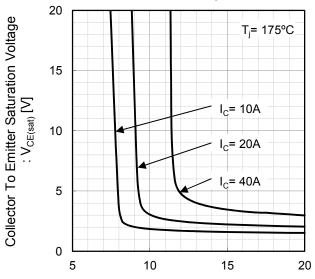


Fig.9 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage



Gate To Emitter Voltage : V<sub>GE</sub> [V]

Fig.10 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage



Gate To Emitter Voltage :  $V_{GE}[V]$ 

Fig.11 Typical Switching Time vs. Collector Current

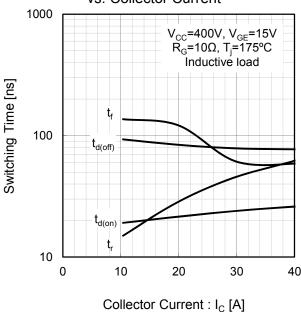
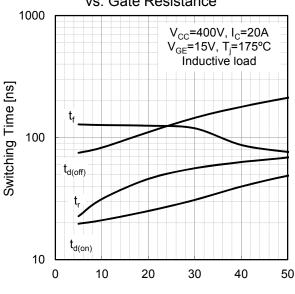


Fig.12 Typical Switching Time vs. Gate Resistance



Gate Resistance :  $R_G[\Omega]$ 

Fig.13 Typical Switching Energy Losses vs. Collector Current 10 Switching Energy Losses [mJ] 1 E<sub>off</sub> Eon 0.1  $V_{CC}$ =400V,  $V_{GE}$ =15V R<sub>G</sub>=10 $\Omega$ , T<sub>j</sub>=175°C Inductive load 0.01 0 10 30 20 40 Collector Current : I<sub>C</sub> [A]

vs. Gate Resistance 10 Switching Energy Losses [mJ] 1  $\mathsf{E}_{\mathsf{off}}$  $\mathsf{E}_{\mathsf{on}}$ 0.1 V<sub>CC</sub>=400V, I<sub>C</sub>=20A V<sub>GE</sub>=15V, T<sub>j</sub>=175°C Inductive load 0.01 0 10 20 30 40 50 Gate Resistance :  $R_G[\Omega]$ 

Fig.14 Typical Switching Energy Losses

Fig.15 Typical Capacitance vs. Collector To Emitter Voltage 10000 Cies 1000 Capacitance [pF] Coes 100 Cres 10 f=1MHz V<sub>GE</sub>=0V T,=25°C 0.1 0.01 10 100 Collector To Emitter Voltage : V<sub>CE</sub>[V]

Fig.17 Typical Diode Forward Current vs. Forward Voltage 60 Forward Current : I<sub>F</sub> [A] 45 30 15 T<sub>i</sub>= 175°C T<sub>i</sub>= 25°C 0 0.5 1.5 2 2.5 3 Forward Voltage : V<sub>F</sub>[V]

Fig.18 Typical Diode Reverse Recovery Time vs. Forward Current 400 V<sub>CC</sub>=400V di<sub>F</sub>/dt=200A/μs Reverse Recovery Time : t<sub>rr</sub> [ns] Inductive load 300 T<sub>i</sub>= 175°C 200 100 T<sub>i</sub>= 25°C 0 20 30 50 0 10 40 Forward Current : I<sub>F</sub> [A]

Fig.19 Typical Diode Reverse Recovery Current vs. Forward Current

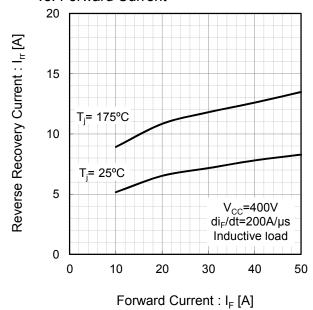


Fig.20 Typical Diode Reverse Recovery Charge vs. Forward Current

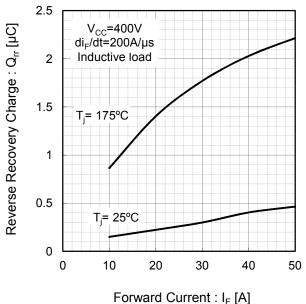


Fig.21 IGBT Transient Thermal Impedance

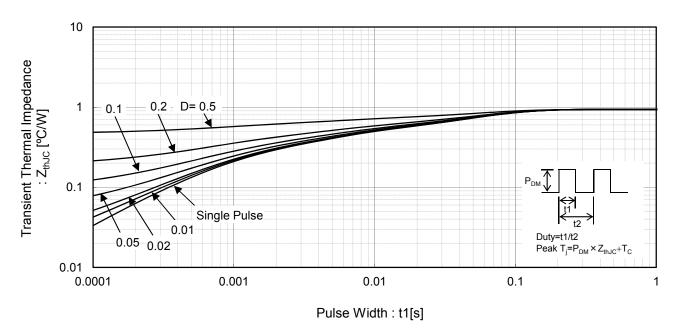
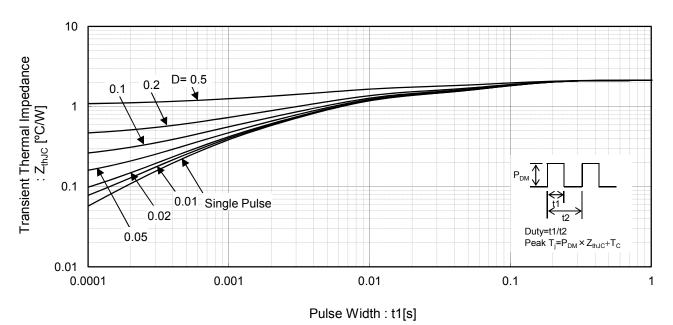


Fig.22 Diode Transient Thermal Impedance



### ●Inductive Load Switching Circuit and Waveform

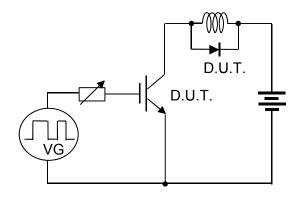


Fig.23 Inductive Load Circuit

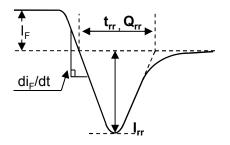


Fig.25 Diode Reverce Recovery Waveform

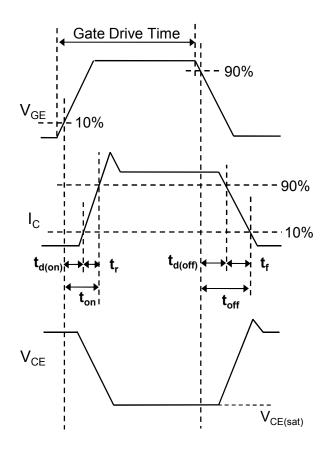


Fig.24 Inductive Load Waveform

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